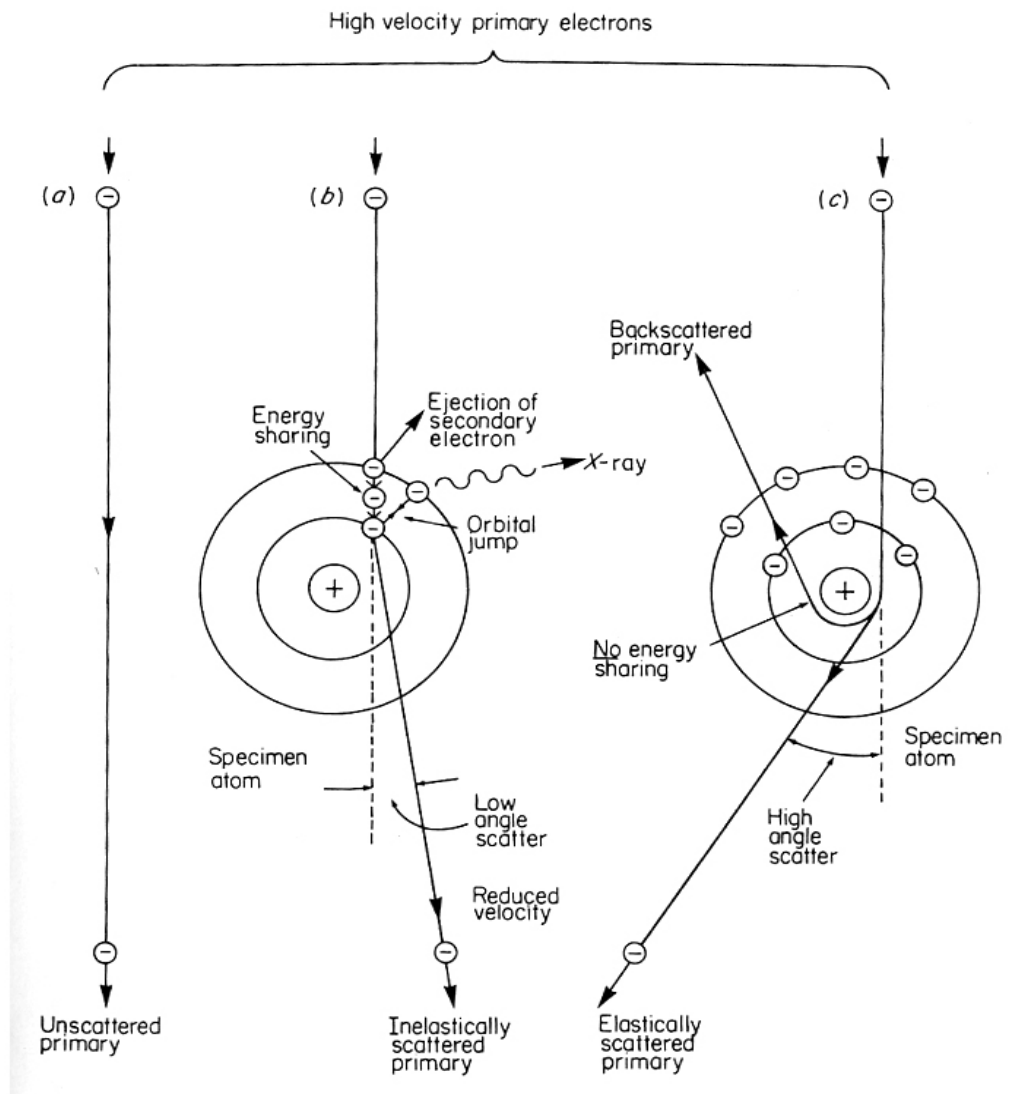
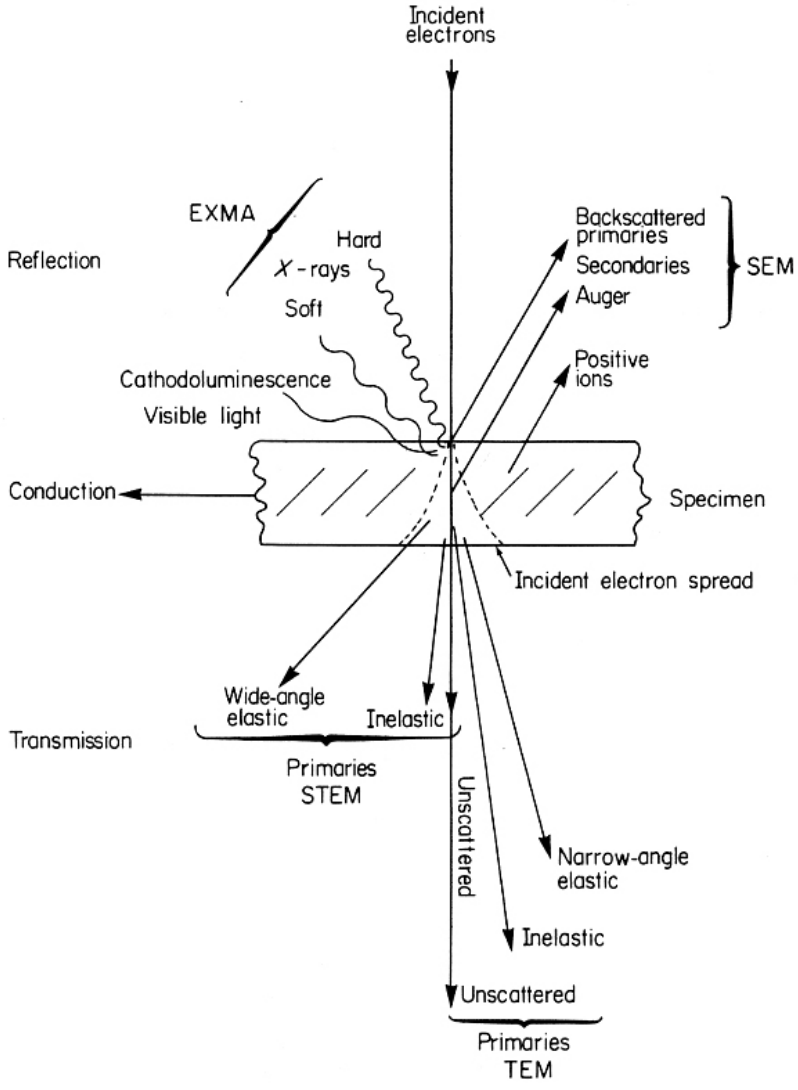


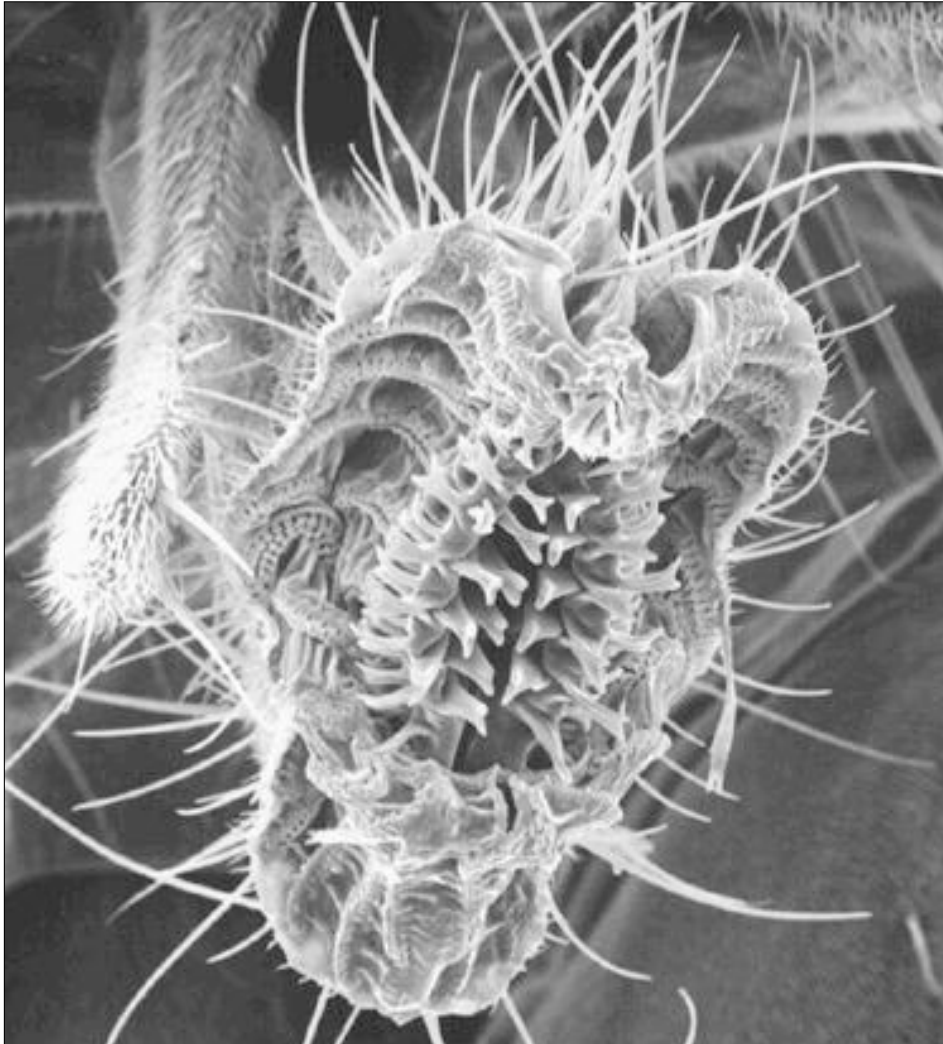
Part 3 - Image Formation



Three classes of scattering outcomes

Types of electron microscopes





Example SEM image:
fly nose

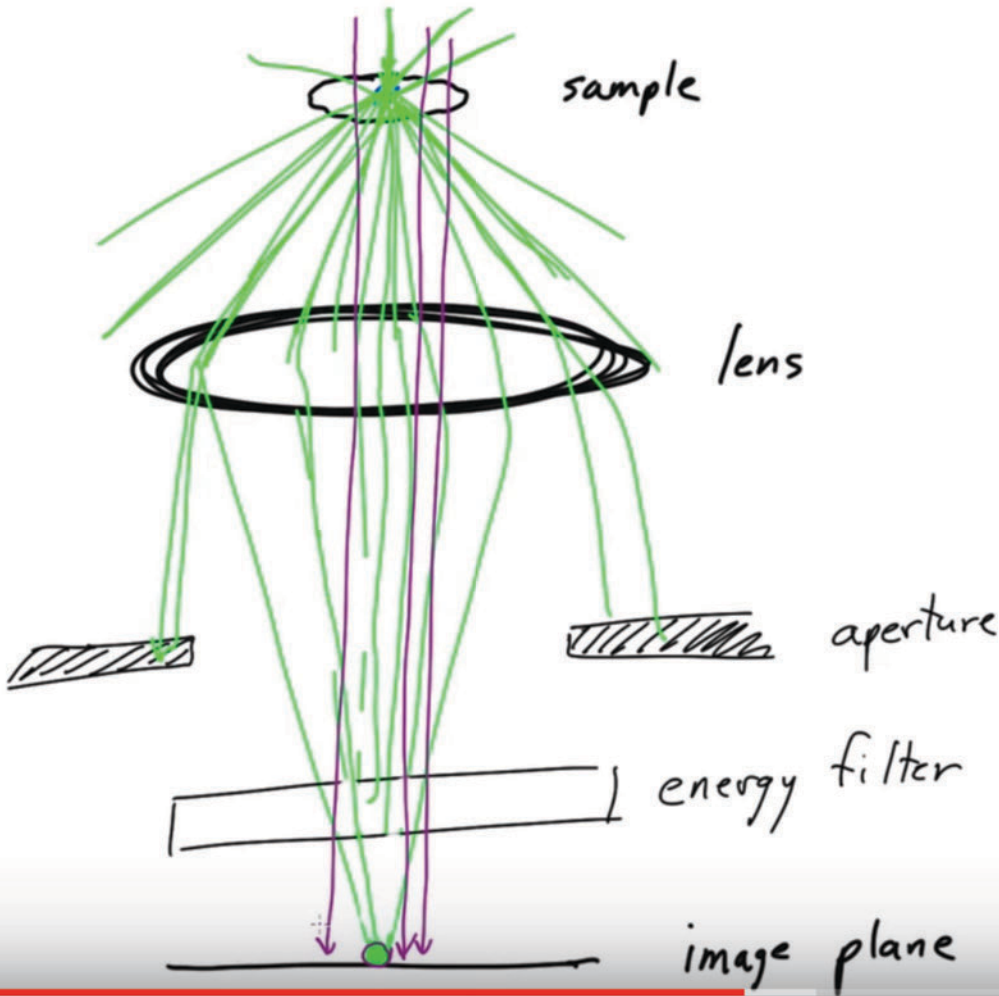


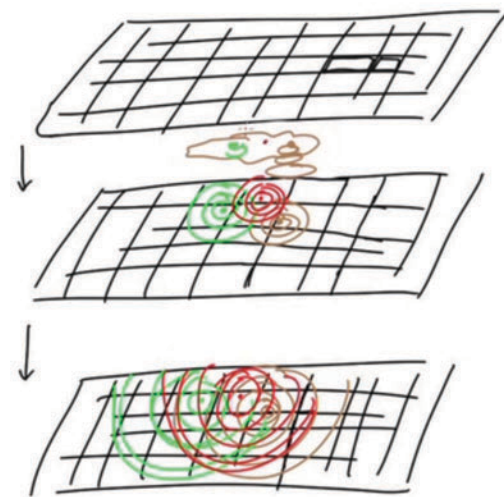
EM: 50,500 X

Example TEM image:
muscle

Skeletal muscle.
Cell and Tissue Ultrastructure
Mercer

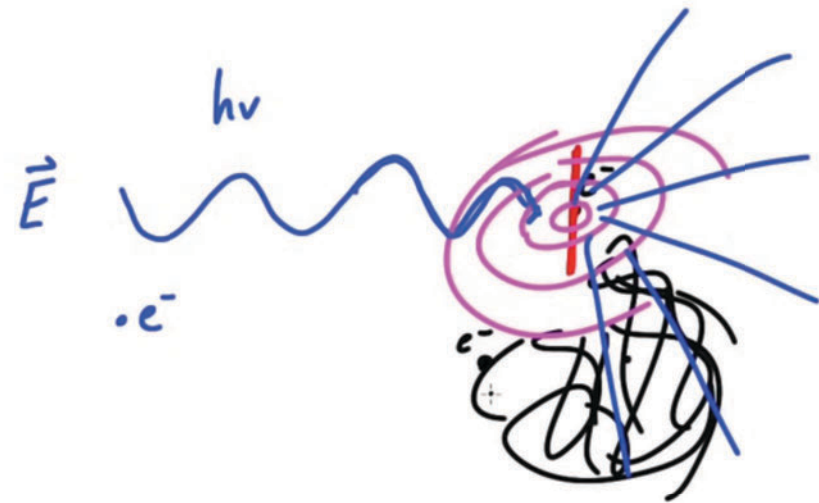
Amplitude contrast





plane wave
 $A=1$ $\theta=0^\circ$



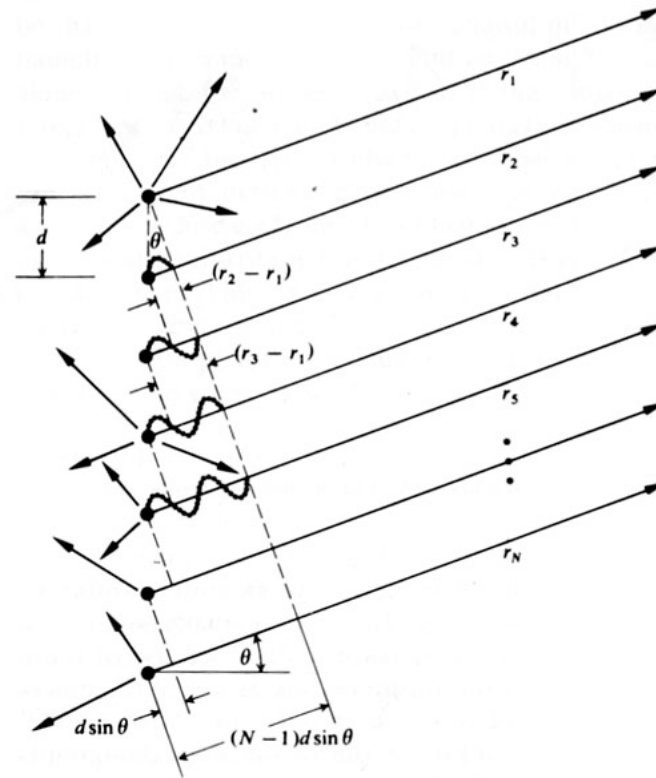
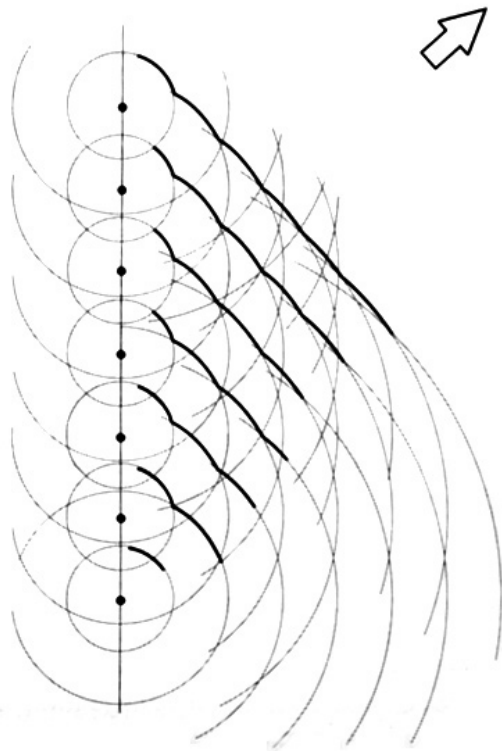


The video displays a man in the bottom-left corner and a whiteboard with several hand-drawn diagrams. The diagrams include:

- A set of four vertical green lines with a horizontal green line and an arrow pointing to the right.
- A central complex diagram featuring a vertical axis with concentric green circles, intersecting black and red lines, and a purple line with an arrow.
- A set of three vertical green lines with a horizontal green line and an arrow pointing to the right.
- Two sets of intersecting diagonal lines (purple and red) with arrows and a Greek letter α .

The video player interface at the bottom shows a progress bar at 15:01 / 30:13 and various control icons.

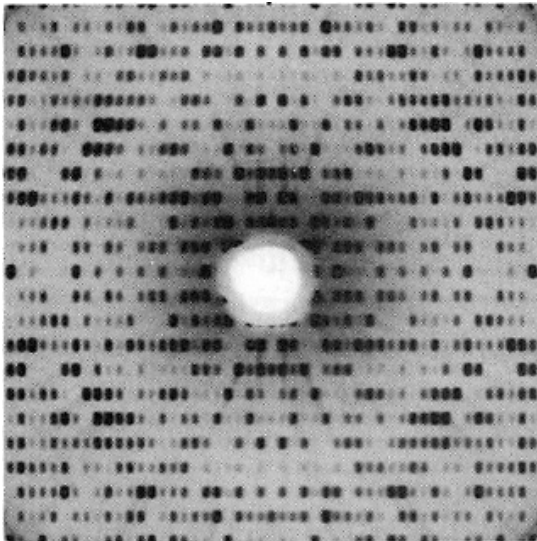
Diffraction can be thought about and predicted using Huygen's construction



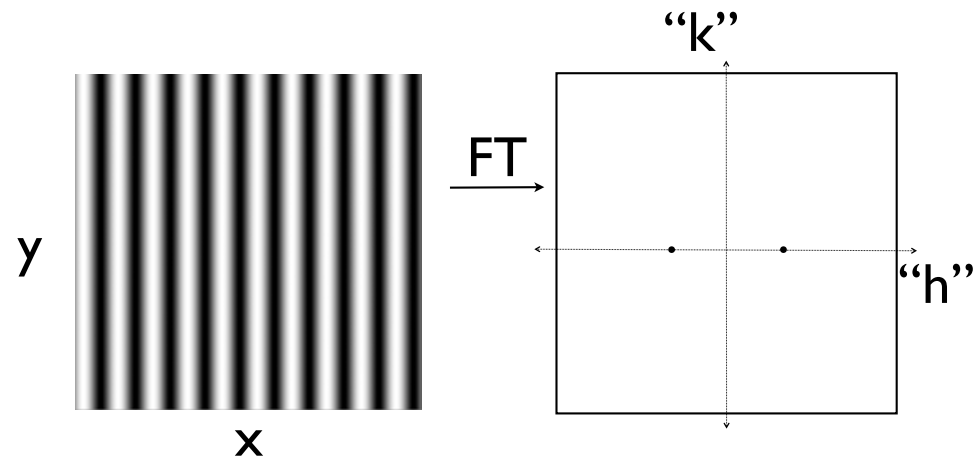
Maxima occur where $n\lambda = d \sin \theta$

The diagram illustrates wave interference. On the left, a vertical axis is labeled z and p . A wave packet is shown with a blue wave and a red wave. The wave packet is composed of several smaller wave packets, each with a blue wave and a red wave. The wave packet is shown as a series of small circles. On the right, several rays diverge from the wave packet. The rays are colored blue and red. A red bracket on the right is labeled with the Greek letter α .

Actual X-ray diffraction pattern



Remember this?

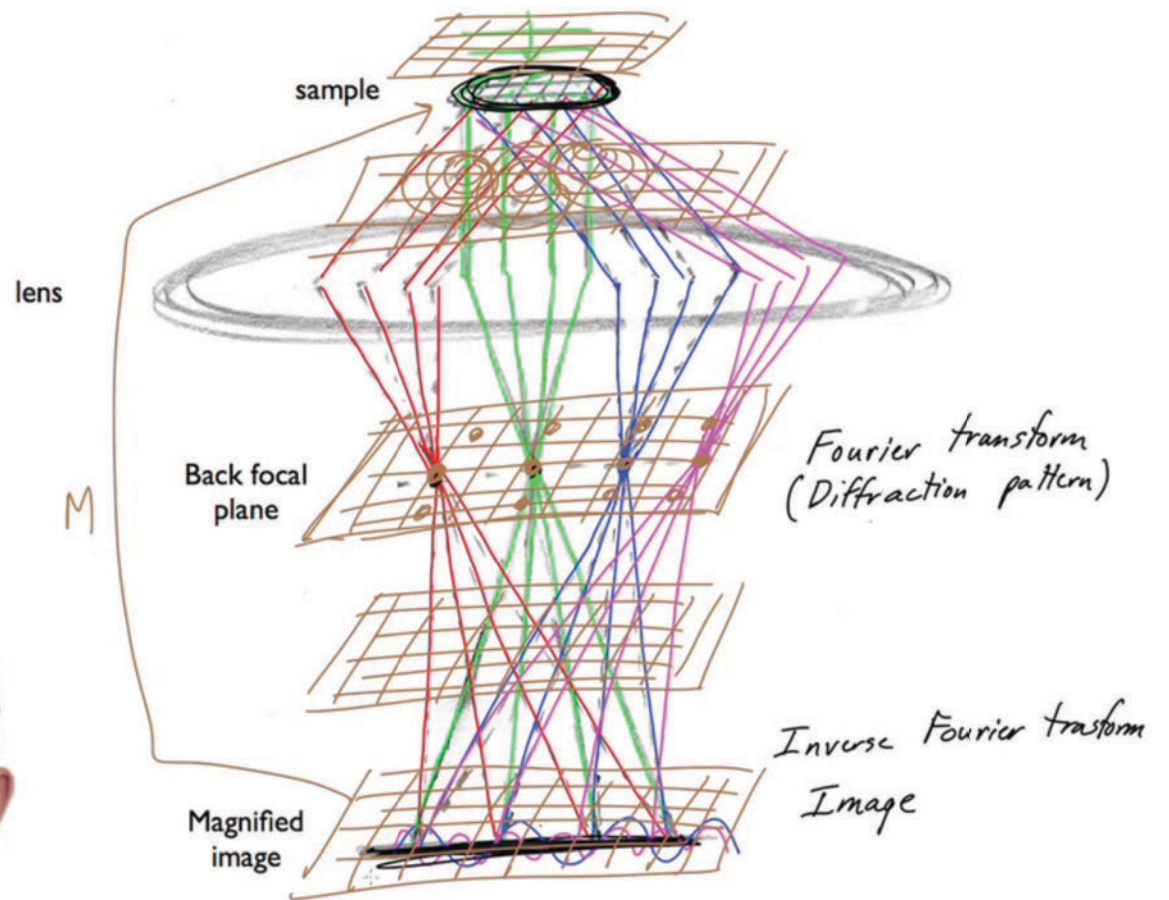


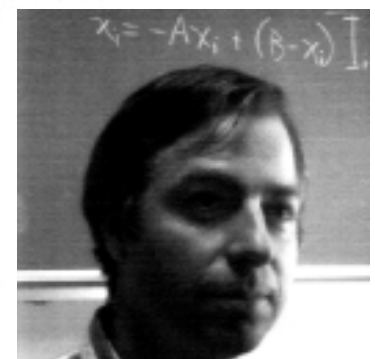
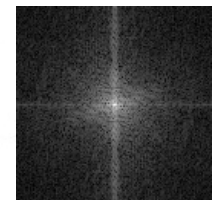
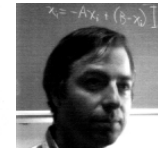
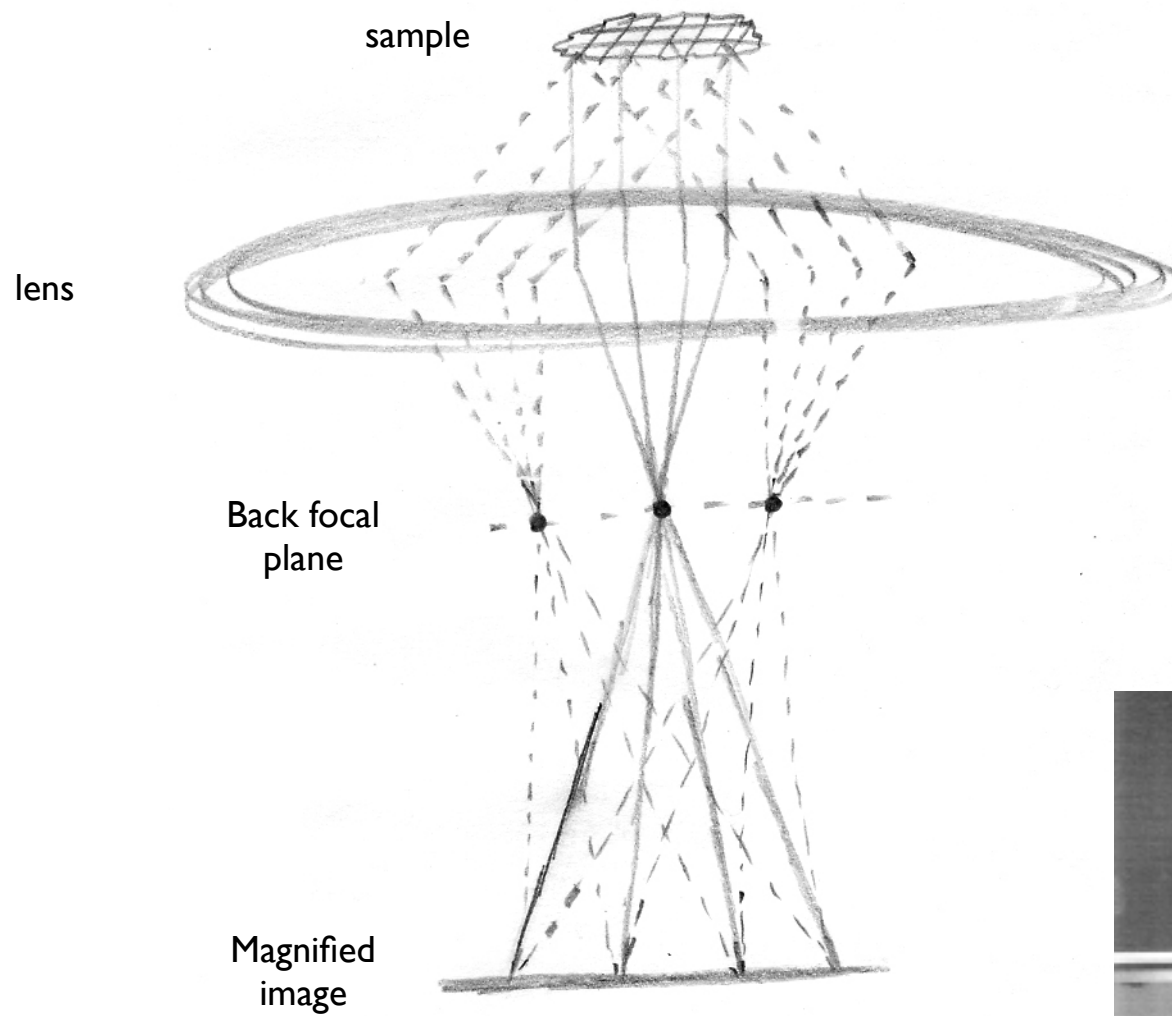
- Each spot represents a Fourier component (a 3-D sine wave)
- Identified by (h, k, l) indices
- Each has an amplitude and a phase
- Both must be known to recalculate the “real space” object

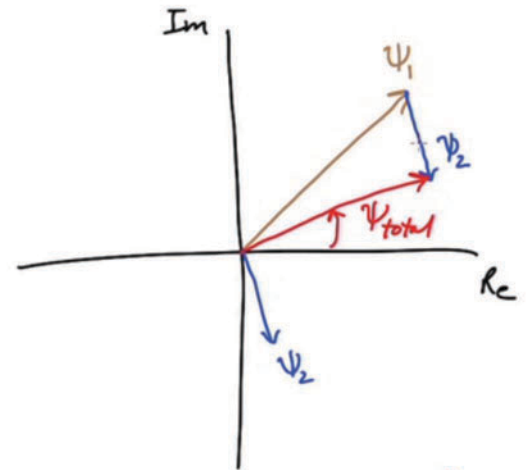
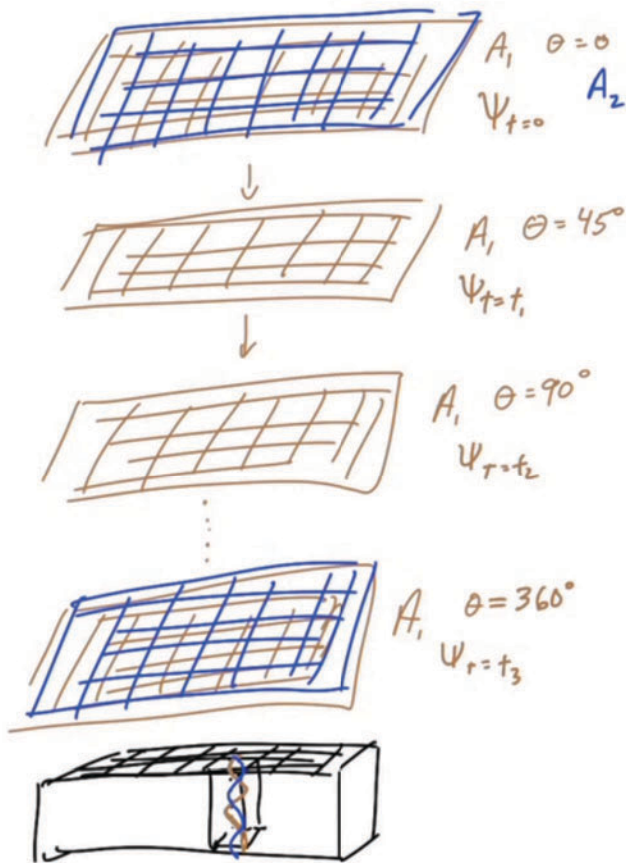
Amplitude and phase contrast

Concept check questions:

- In what ways are inelastic and elastic scattering different? What causes them?
- What signals emerge from scattering events in the electron microscope that can be measured, and how do they lead to the three main types of electron microscopy?
- How does amplitude contrast arise?
- Why is it easier to explain amplitude contrast if we envision imaging electrons as particles?
- Why does phase contrast require us to think of imaging electrons as waves?
- What is a “plane wave”? What about a plane wave changes as it travels through a vacuum?
- Explain how/why atoms scatter X-rays.
- Why are there discrete peaks in the scattering from crystals?
- What information is delivered by each peak?

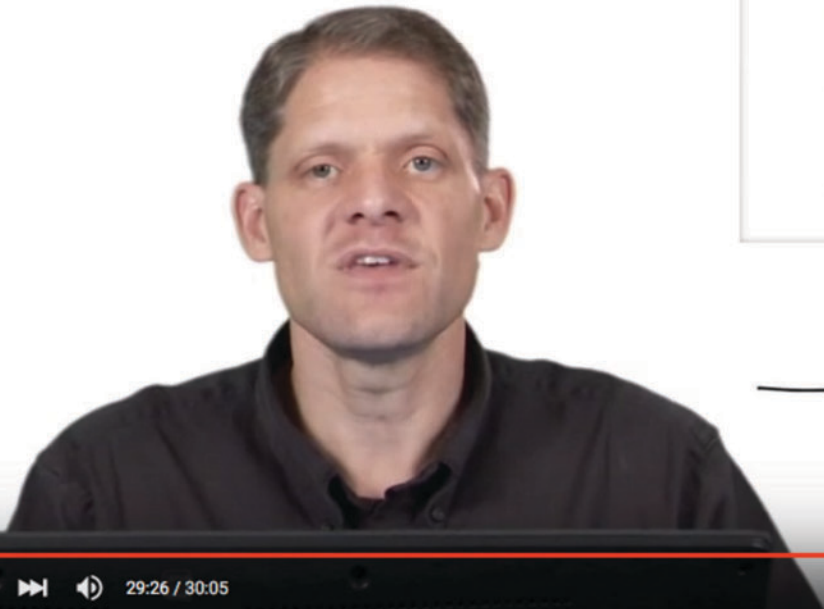
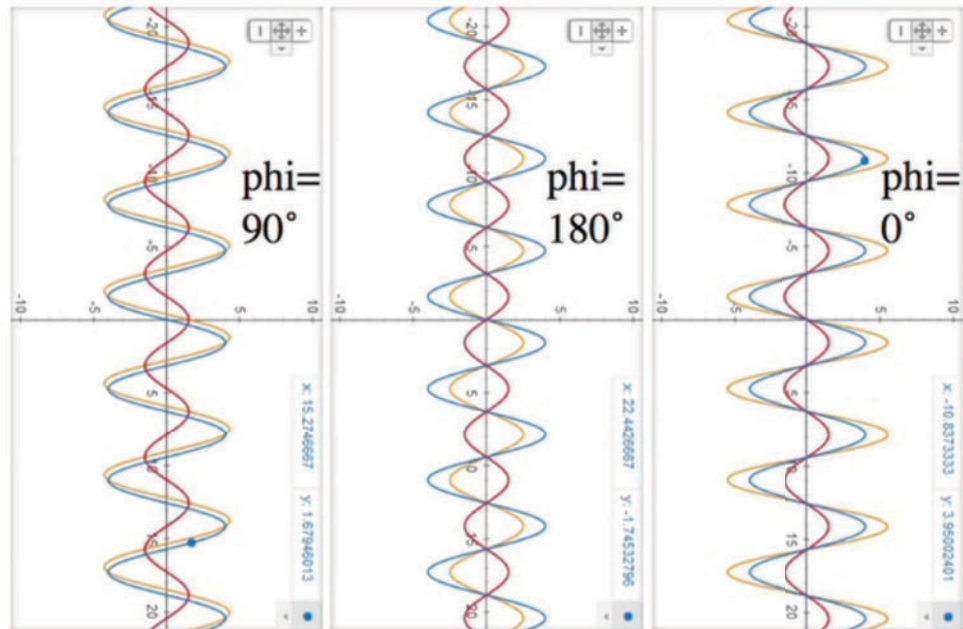






$|\Psi_{total}|^2 = \text{probability of detection in any particular pixel}$

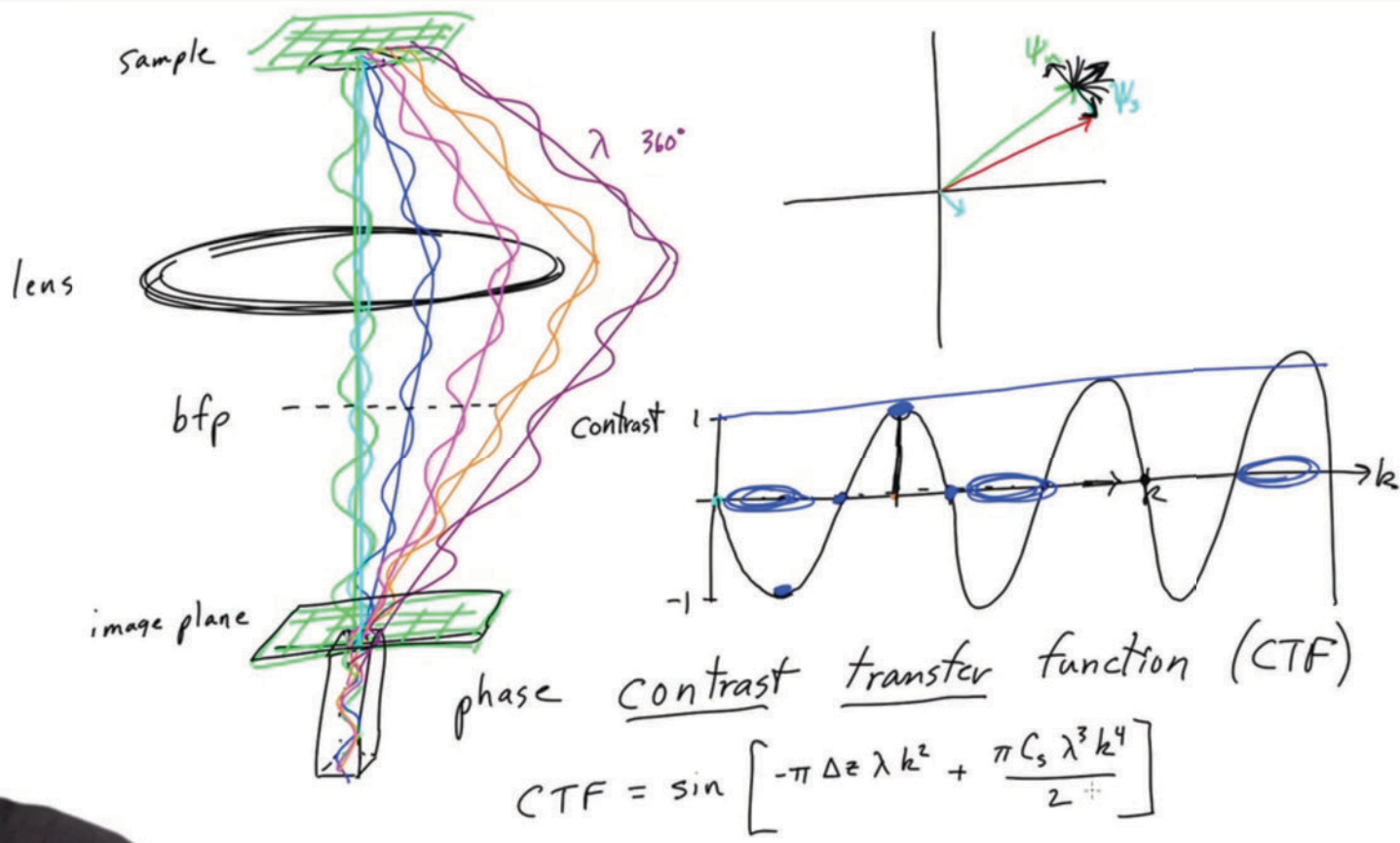
$$\underline{4\sin(x)} + \underline{1.5\sin(x+\phi)}$$



Wave propagation and phase shifts

Concept check questions:

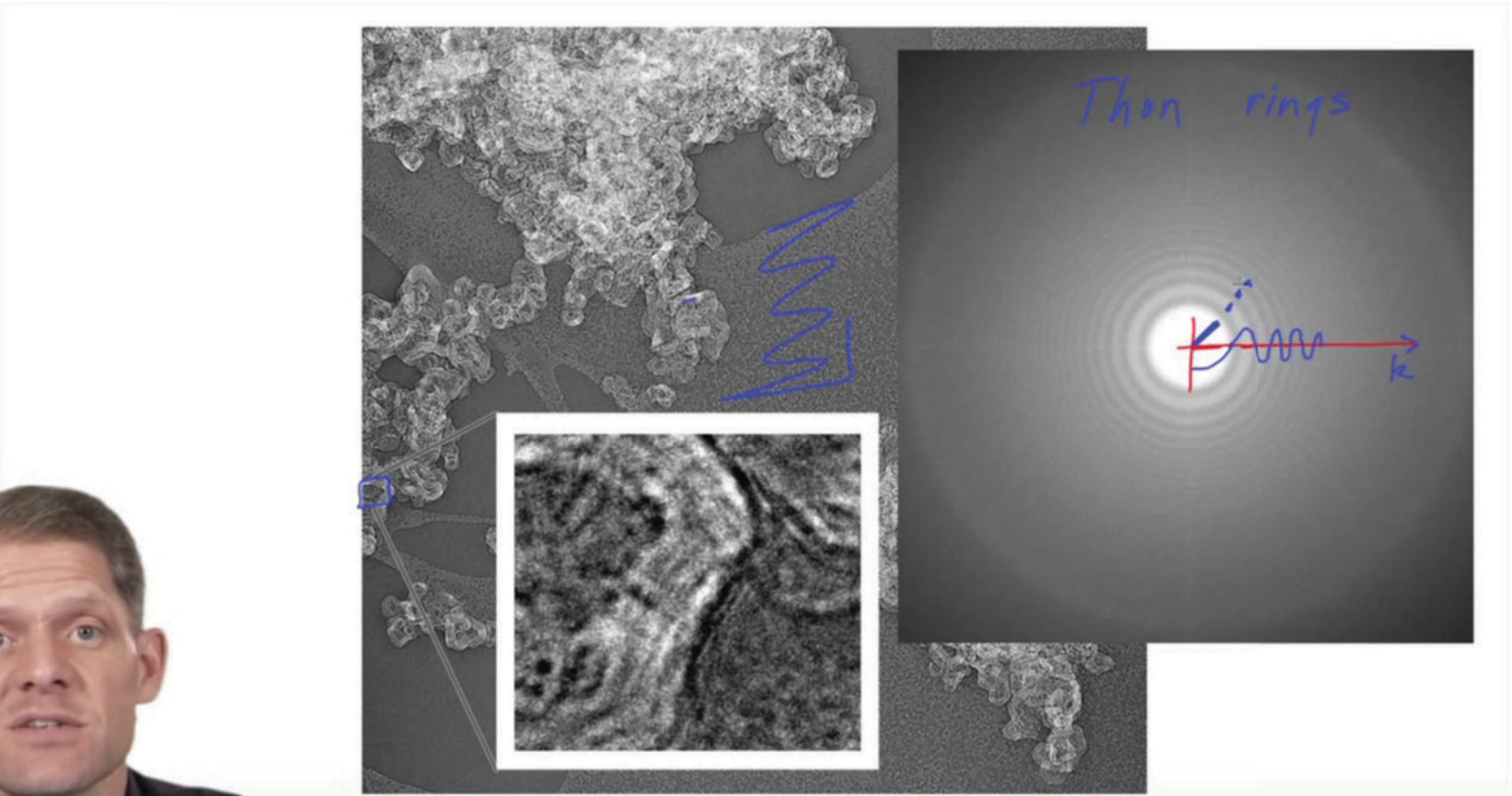
- How is the scattering from an object converted into an image in a microscope?
- What is the relationship between the density of the sample and the wavefunction present on the back focal plane of the objective lens? The image plane? Can you draw a picture showing why?
- How are plane waves represented in an “Argand” diagram? What are the axes?
- Why were Argand diagrams introduced (how do they help us understand wave propagation and interference)?
- How does the phase difference between two waves of identical frequency affect their interference?
- What property of an electron wave gives the probability of its detection at each position?



The contrast transfer function

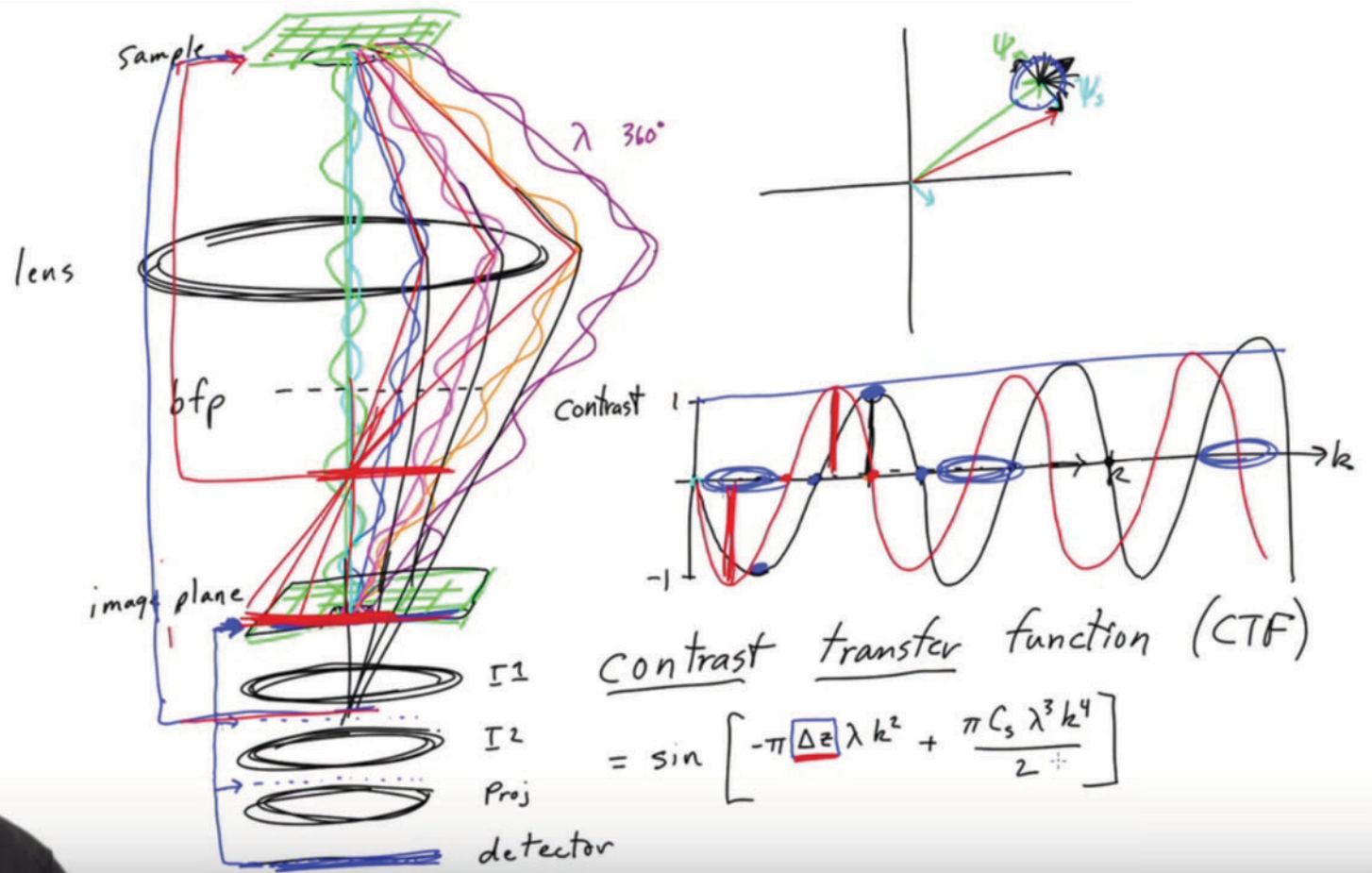
Concept check questions:

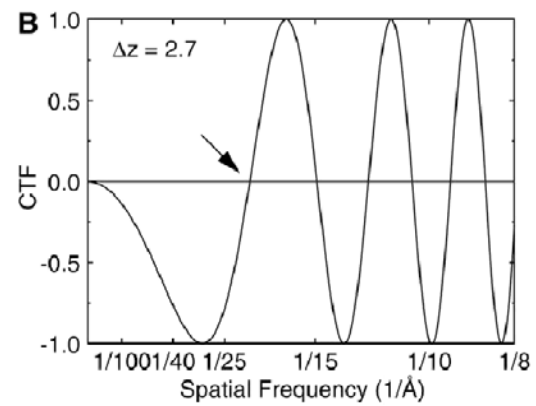
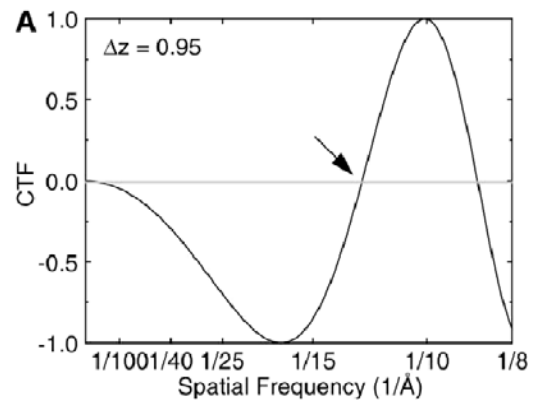
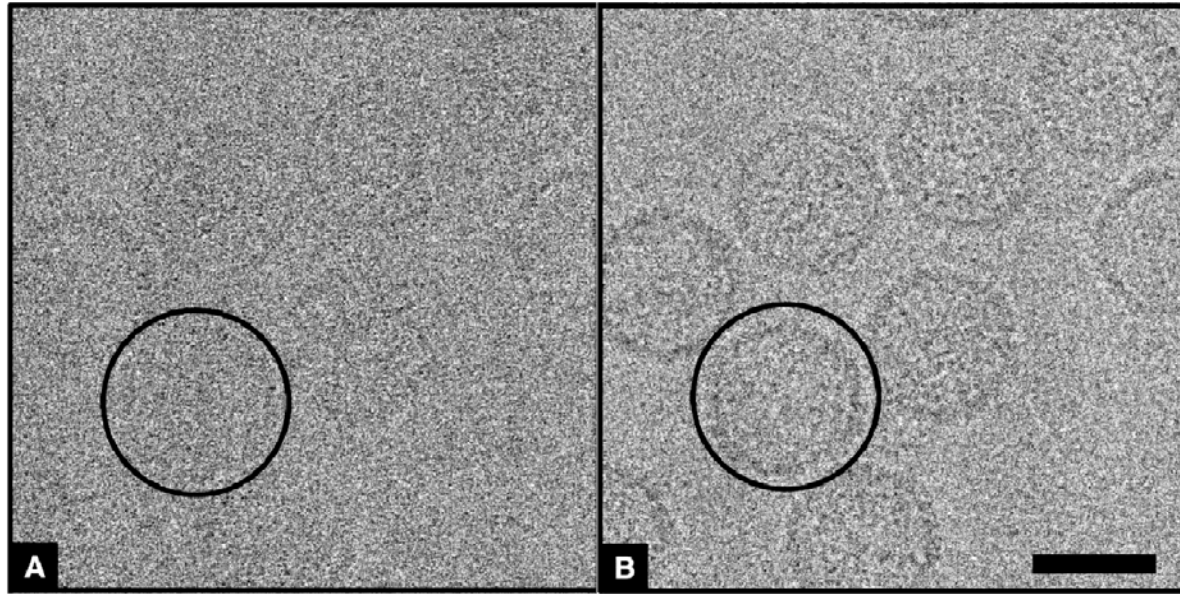
- What two factors make the phase of a scattered component of a wave different from that of an unscattered component?
- The contrast transfer function is typically plotted as a sinusoidally-varying function of what variable (what is the horizontal axis)? What quantity is plotted on the vertical axis?
- What is the CTF's domain and range?
- What does a “contrast transfer” of 1.0 mean? -1? 0?
- Why does the CTF oscillate sinusoidally?
- What four variables appear in the argument of the sine function?



⏪ ⏩ 🔊 4:02 / 21:28

⚙️ HD 🖥️ 🗄️



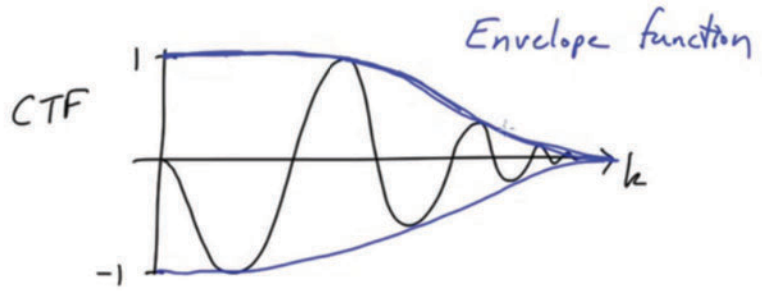
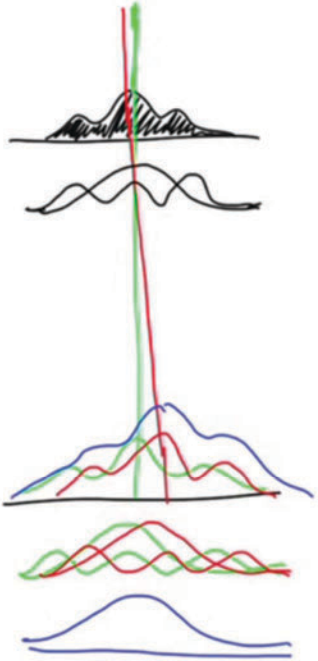


Thuman-Commike and Chiu, *Micron* **31**:687

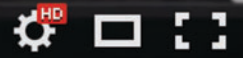
Defocus and its effects

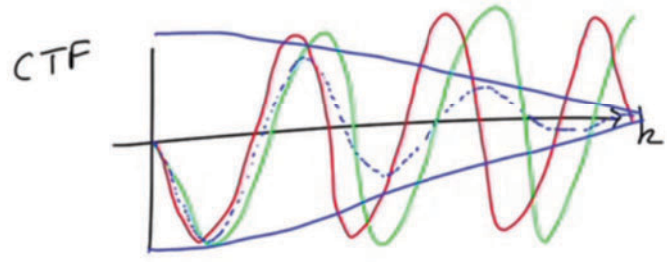
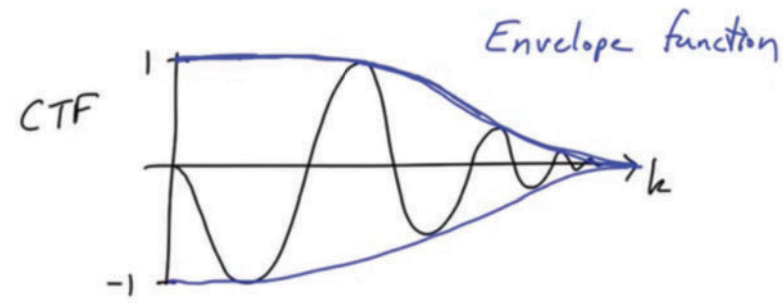
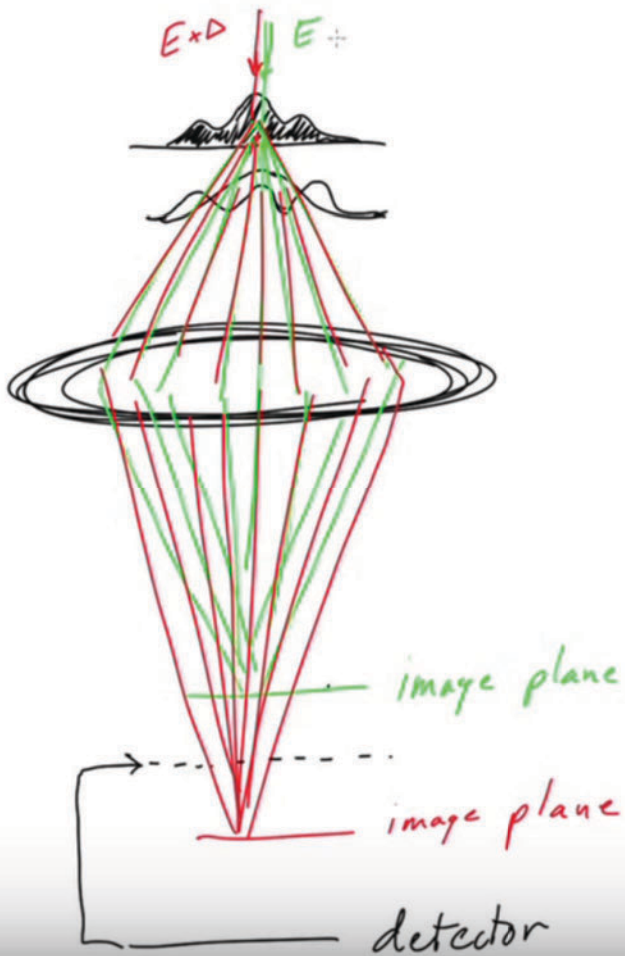
Concept check questions:

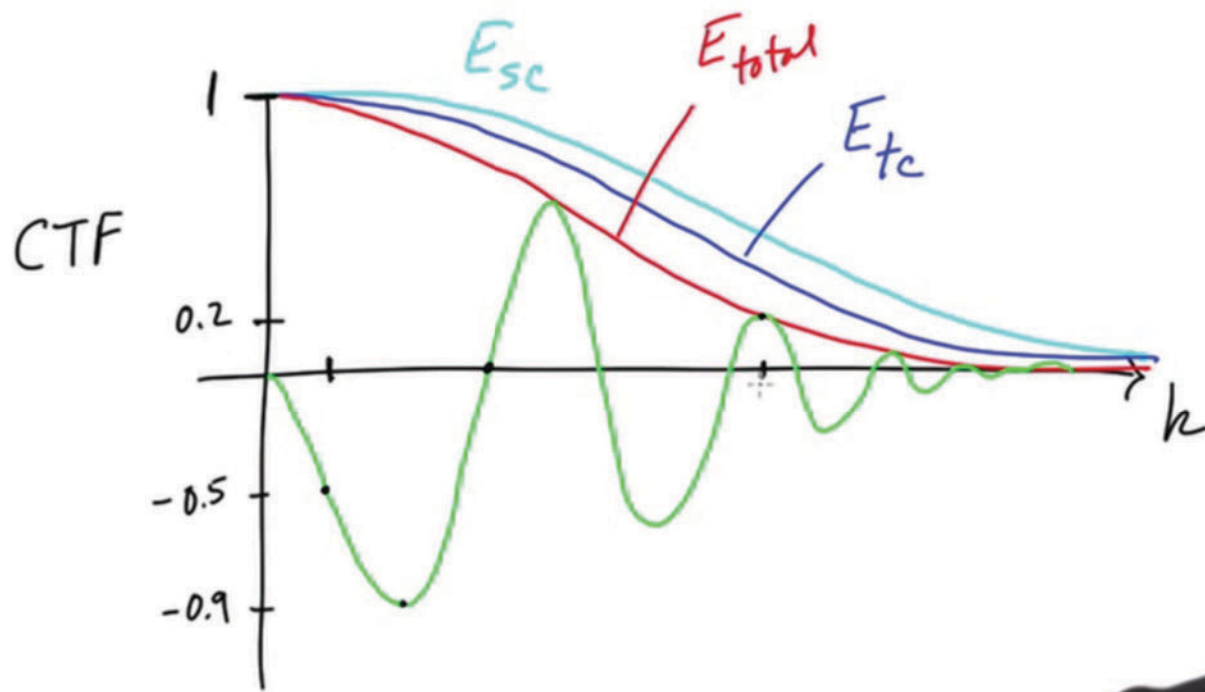
- What is a “Thon” ring?
- How can the defocus of a TEM image be determined?
- Why is defocus part of the argument of the CTF sine function?
- Does increasing the current in the objective lens make the image more or less defocussed?
- What is “over-focus”?
- How do heavily defocussed images look different than “closer-to-focus” images?
- What are the advantages of taking pictures far from focus? close to focus?

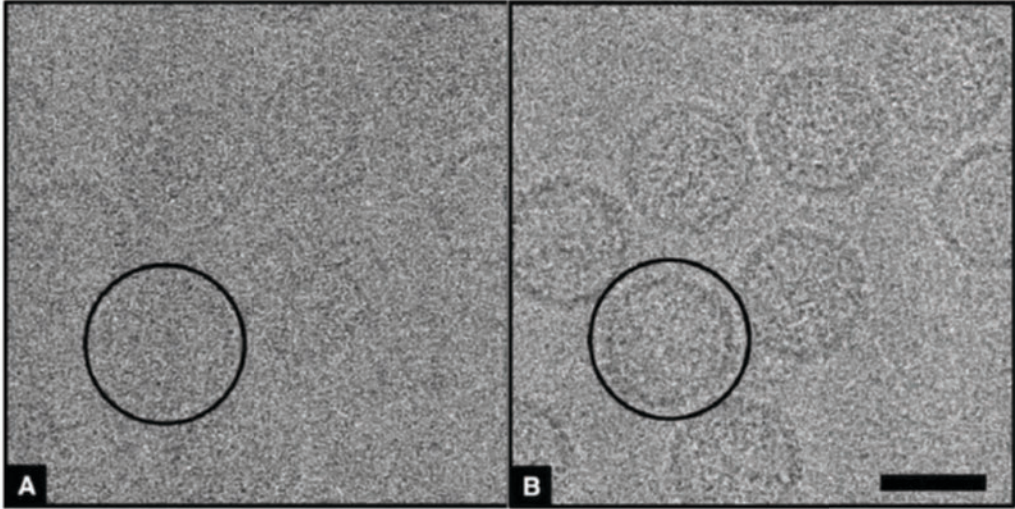


⏮ ⏪ ⏩ ⏭ 🔊 6:01 / 16:20



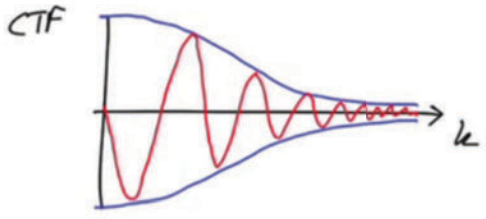
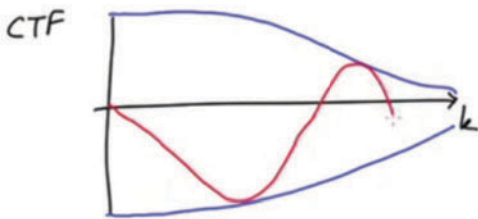






low Δz

high Δz



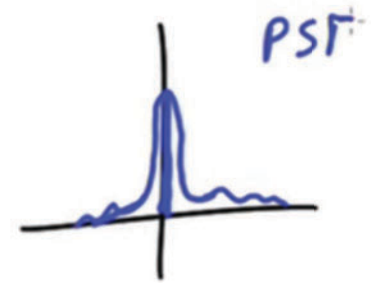
Thuman-Commike and Chiu, *Micron* 31:687

Envelopes

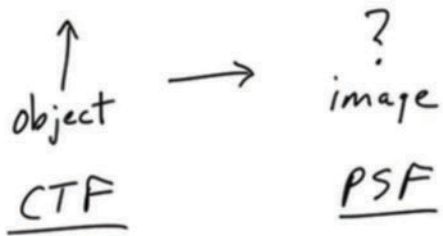
Concept check questions:

- What effect does partial spatial coherence have on the CTF? Why?
- What effect does partial temporal coherence have on the CTF? Why?
- What is their combined effect?
- How do these effects depend on defocus?

Point spread function PSF



$$PSF = \mathcal{F}\{CTF\}$$



convolution

$$I = O \otimes PSF$$

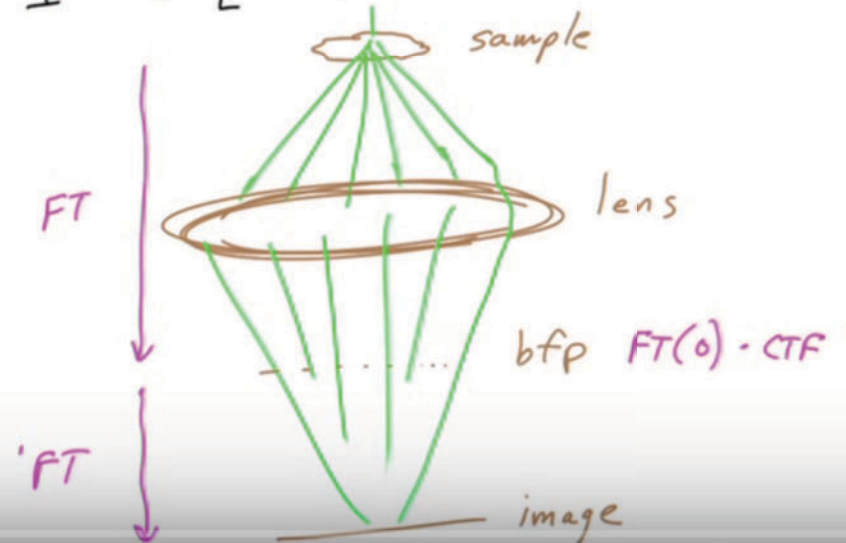
$$I = O \otimes PSF$$

$$\mathcal{F}\{I\} = \mathcal{F}\{O \otimes PSF\}$$

$$= \mathcal{F}\{O\} \cdot \mathcal{F}\{PSF\}$$

$$\mathcal{F}\{I\} = \mathcal{F}\{O\} \cdot CTF$$

$$I = \mathcal{F}^{-1}[\mathcal{F}\{O\} \cdot CTF]$$



$$\mathcal{F}\{O\} = \frac{\mathcal{F}\{I\}}{\text{CTF}}$$

$$O = \mathcal{F}^{-1} \left[\frac{\mathcal{F}\{I\}}{\text{CTF}} \right]$$

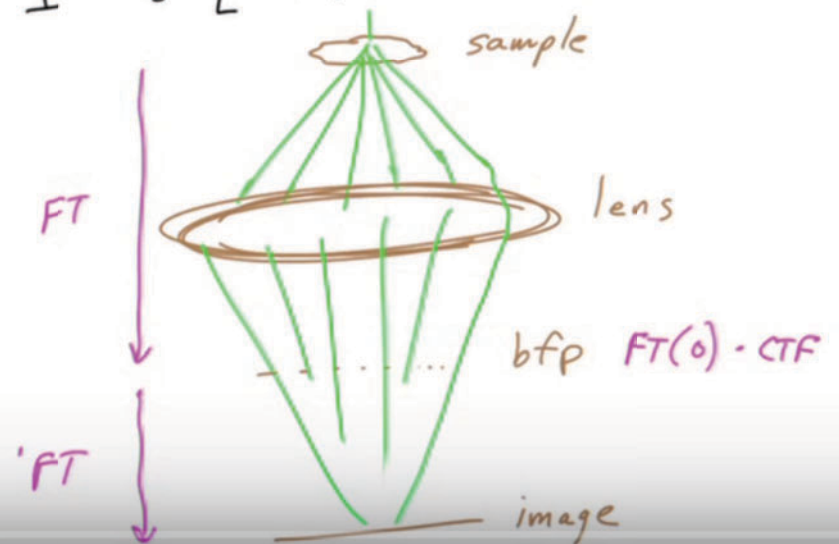
CTF correction:

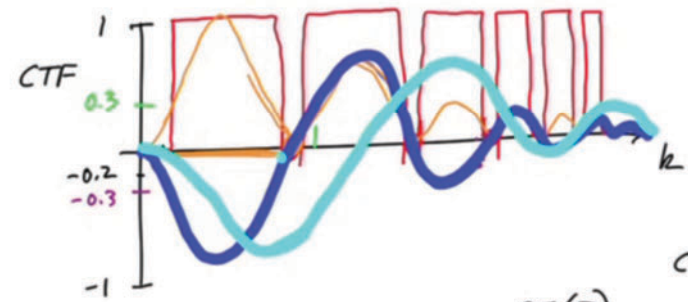
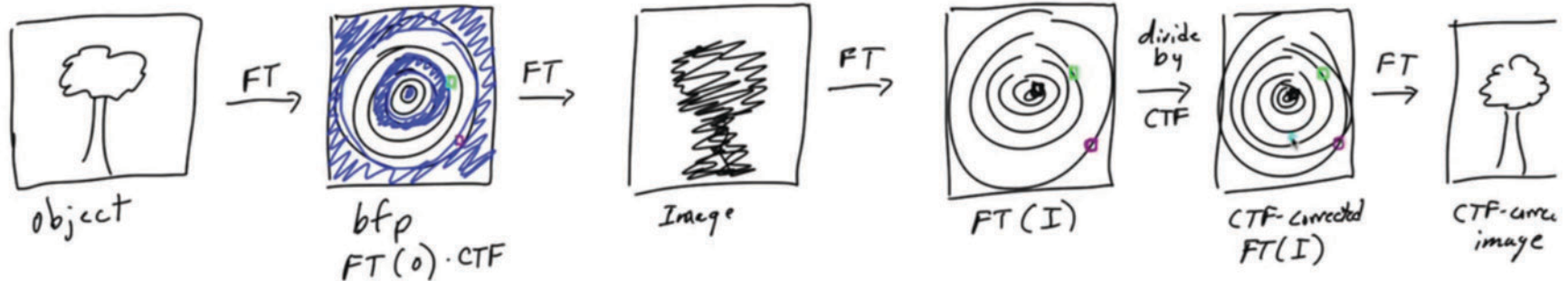
$$I = O \otimes \text{PSF}$$

$$\begin{aligned} \mathcal{F}\{I\} &= \mathcal{F}\{O \otimes \text{PSF}\} \\ &= \mathcal{F}\{O\} \cdot \mathcal{F}\{\text{PSF}\} \end{aligned}$$

$$\mathcal{F}\{I\} = \mathcal{F}\{O\} \cdot \text{CTF}$$

$$I = \mathcal{F}^{-1} \left[\mathcal{F}\{O\} \cdot \text{CTF} \right]$$



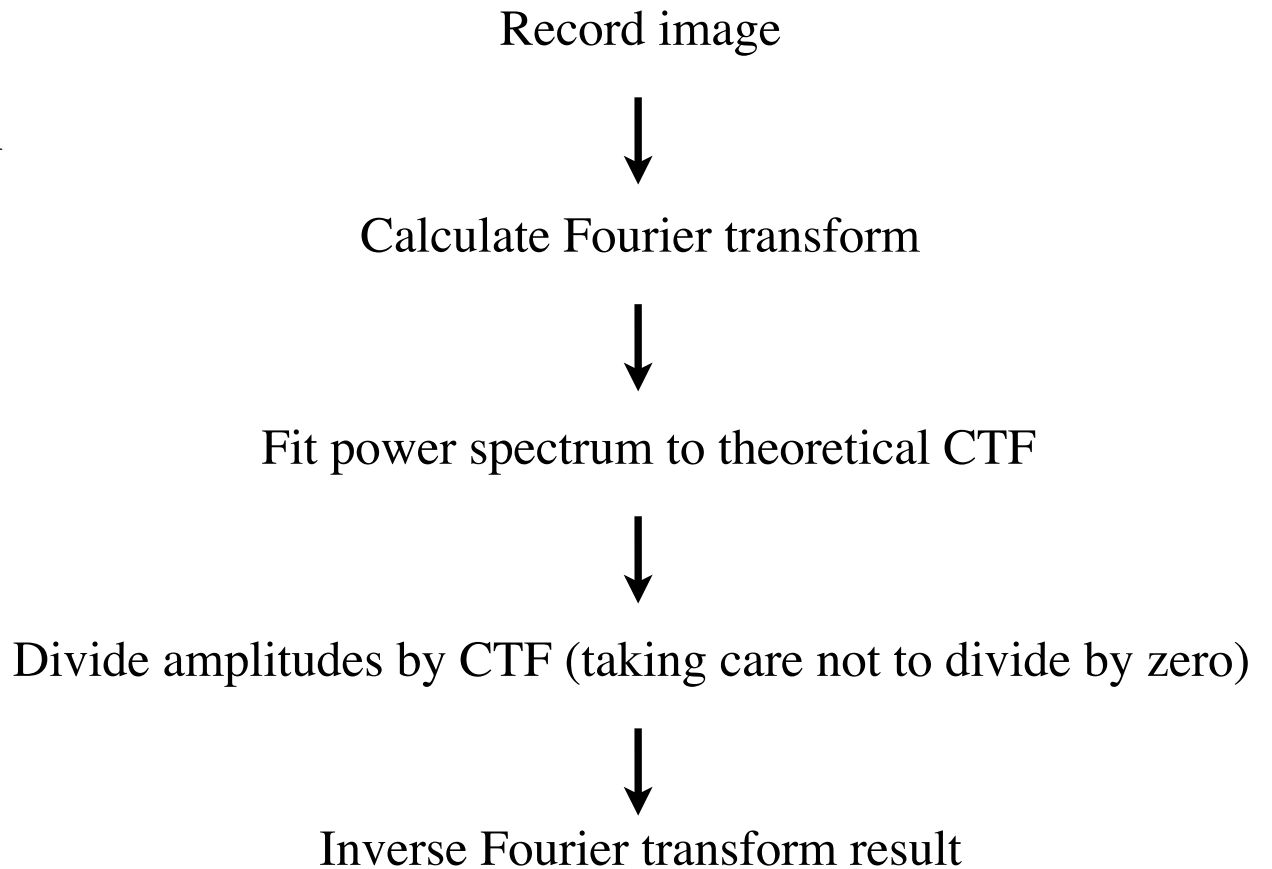


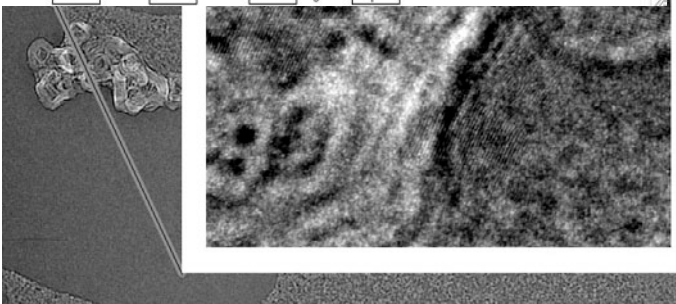
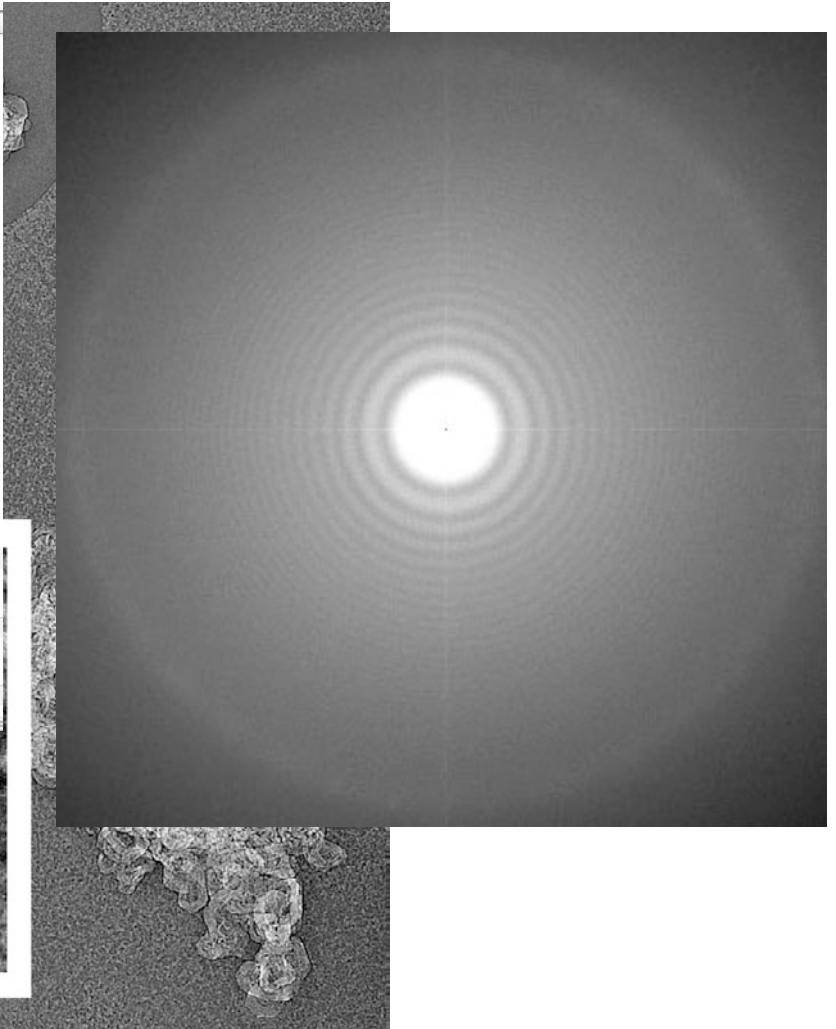
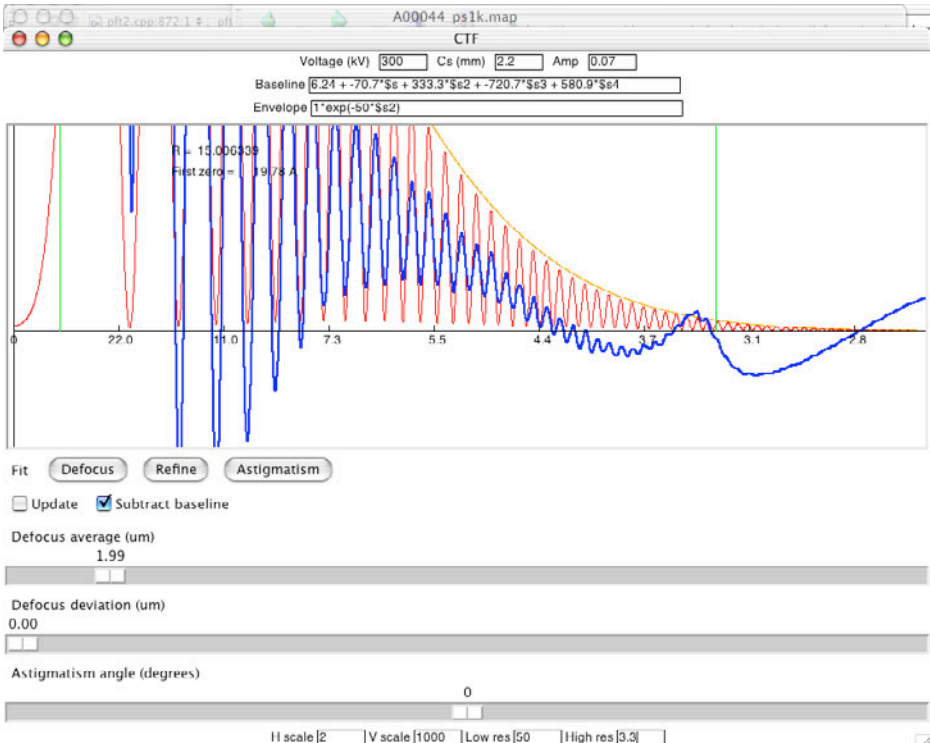
"phase-flipping"

	object	CTF	FT(I)	CTF-corrected FT(I)
A	10	-0.2	-2	$\frac{-2}{-0.2} = 10$
	5	0.3	1.5	$\frac{1.5}{0.3} = 5$
	2	-0.3	-0.6	$\frac{-0.6}{-0.3} = 2$



CTF correction





CTF correction

Concept check questions:

- What is a “point spread function”?
- How is the point spread function related to the CTF?
- What is the relationship between the wavefunction that exists on the back focal plane of the microscope and the Fourier transform of the recorded image?
- How (conceptually) can EM images be “CTF-corrected”?
- How can the CTF of a TEM image be determined?
- What special issue arises at CTF-zeros? How can it be handled?
- What would it mean if someone said they “CTF-corrected by phase-flipping only”?
- How can the information loss at CTF-zeros be overcome?